Notification Number: 20151117000						Notification Date: 11/19/2015			
Title: Datasheet update for LM5160-Q1									
Customer Co	Customer Contact: PCN Manager		<u>[</u>			Dept:		Quality Services	
Change Type	e:								
Assembly	/ Site		Design				Wafer	Bump Site	
Assembly Process		🛛 Data Sh	🛛 Data Sheet			Wafer Bump Material			
Assembly Materials		Part nur	Part number change			Wafer Bump Process			
Mechanical Specification			Test Site			Wafer Fab Site			
Packing/Shipping/Labeling		Test Pro	Test Process			Wafer Fab Materials			
<u> </u>						Wafer Fab Process			
Notification Details									
Description of Change:									
Texas Instruments Incorporated is announcing an information only notification. The product datasheet(s) is updated as seen in the change revision history below: Image: Changes from Original (July 2015) to Revision A Page • Changed current limit off-timer in the Electrical Characteristics to 16									
The datasheet number will be changing.									
Device Family			Change From: SNVSAE4			Change To: SNVSAE4A			
LM5160-Q1			SIVSA	SINVSAE4			SNVSAE4A		
These changes may be reviewed at the datasheet links provided. http://www.ti.com/product/lm5160-q1									
Reason for Change:									
To more accurately reflect device characteristics.									
Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):									
No anticipated impact. This is a specification change announcement only. There are no changes to the actual device.									
Changes to product identification resulting from this Notification:									
None.									
Product Affected:									
LM5160AQPV	VPQ1	LM5160A	QPWPTQ1	1 LM5160QPWP		Q1 PLM5		160AQPWPQ1	
LM5160AQPV		LM5160Q		LM5160QPWP				160QPWPTQ1	
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For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com